

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/618,102	ORR, RICHARD S.	
	Examiner	Art Unit	
	Van Kim T. Nguyen	2661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,587,511	07-2003	Barak et al.	375/295
	B	US-6,556,814	04-2003	Klomsdorf et al.	455/121
	C	US-6,515,961	02-2003	Weaver et al.	370/206
	D	US-6,512,417	01-2003	Booth et al.	330/149
	E	US-6,396,826	05-2002	Ohlson et al.	370/342
	F	US-6,449,303	09-2002	Hunton, Matthew J.	375/130
	G	US-6,445,749	09-2002	Feher, Kamilo	375/298
	H	US-6,404,823	06-2002	Grange et al.	375/297
	I	US-6,393,047	05-2002	Popovic', Branislav M.	375/140
	J	US-6,373,902	04-2002	Park et al.	375/296
	K	US-6,349,216	02-2002	Alberth et al.	455/550.1
	L	US-5,903,555	05-1999	Wildauer et al.	370/342
	M	US-5,848,105	12-1998	Gardner et al.	375/336

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.